

Notice of References Cited	Application/Control No. 10/034,012	Applicant(s)/Patent Under Reexamination PARKER ET AL.	
	Examiner Kristie Shingles	Art Unit 2141	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0122416	09-2002	Xu et al.	370/352
*	B	US-2002/0141384	10-2002	Liu et al.	370/352
*	C	US-2002/0042832	04-2002	Fallentine et al.	709/230
*	D	US-6,697,377	02-2004	Ju et al.	370/466
*	E	US-2002/0114322	08-2002	Xu et al.	370/352
*	F	US-2003/0009561	01-2003	Sollee, Patrick N.	709/227
*	G	US-2002/0078198	06-2002	Buchbinder et al.	709/224
*	H	US-2004/0037268	02-2004	Read, Stephen Michael	370/352
*	I	US-2004/0095937	05-2004	Piche et al.	370/392
*	J	US-2002/0184316	12-2002	Thomas et al.	709/206
*	K	US-6,779,039	08-2004	Bommareddy et al.	709/238
*	L	US-6,360,265	03-2002	Falck et al.	709/227
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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